

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10090499	DEZONNO ET AL.
	<b>Examiner</b> MATTHEW W GENACK	<b>Art Unit</b> 2617

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Reviewed IDS documents	3/4/2005	MG
Consulted with Primary Examiner Roland Foster	3/4/2005	MG
Conducted keyword search (See search history printout)	3/4/2005	MG
379/201.01-03, 201.07-.09, 221.1, 221.11-.13, 265.01-03, 266.03-.09 (Limited text search---see search history printout)	3/4/2005	MG
Updated keyword search (See search history printout)	7/23/2005	MG
Updated keyword search (See search history printout)	2/3/2006	MG
Reviewed IDS documents	10/16/2006	MG
Updated keyword search (See search history printout)	10/16/2006	MG
Updated keyword search (See search history printout)	3/27/2007	MG
Updated keyword search (See search history printout)	12/19/2007	MG
Updated keyword search (See search history printout)	9/17/2008	MG
Updated keyword search (See search history printout)	5/12/2009	MG
Conducted NPL search with IEEE Xplore (See IEEE Xplore search printouts)	5/12/2009	MG
Consulted with Primary Examiner James Wozniak	5/12/2009	MG

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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